Notice of References Cited Application/Control No. 10/586,100 Examiner Christopher R. Lea Applicant(s)/Patent Under Reexamination SYED ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,989,530	11-1999	Lorenz et al.	424/62
	В	US-			
	O	US-			
	ם	US-			
	Е	US-			
	F	US-			
	G	US-			
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	K	US-	1		
	Ĺ	US-	1		
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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